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Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/813,774	CHAN ET AL.	
Examiner	Art Unit	
Andrew Wendell	2618	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
East Search		4/4/2006	a,w.
East Search		4/7/2006	۵،٤٠
East Search		4/11/2006	a,w.
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